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# Influence of O<sub>2</sub>, H<sub>2</sub>O and airborne hydrocarbons on the properties of selected 2D materials

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This paper reviews the effect of ambient exposure on the properties of selected 2D materials. Many molecules in ambient air can adsorb onto 2D material surfaces to impact their properties and device performance. This paper highlights recent work on the interaction between 2D materials and three ambient-present molecules: O<sub>2</sub>, H<sub>2</sub>O, and airborne hydrocarbons. We focus our discussions on graphene but also include research on other 2D materials, such as BN, transition metal dichalcogenides, and 2D heterostructures. We discuss the molecular mechanism of their interactions with 2D materials and the impact on electrical, optical, and wetting properties and device performances.

## 1 Background

2D materials include (semi)metals, semiconductors, and insulators. They have been used in a wide range of applications such as electrochemistry, electronics, and optoelectronics. All atoms of 2D materials are on or near the surface. The nanoscale thinness of 2D materials is key to many of their applications, such as the vertical tunnelling field effect transistors (FETs),<sup>1</sup>

and electrically tunable optical absorbers.<sup>2</sup> For the same reason, many properties of 2D materials will change upon surface adsorption of molecules present in the ambient; in many cases, such processes will negatively impact the material performance and contribute to inconsistency and irreproducibility of the experimental results. Therefore, it is important to understand and control the environmental impact in order to achieve the full potential of 2D materials. These issues are receiving increasing attentions, in part due to the need to improve performance, consistency, and reproducibility of devices fabricated from 2D materials.

This paper reviews the effect of ambient environments on the properties of 2D materials, focusing on three molecules: O<sub>2</sub>, H<sub>2</sub>O, and airborne hydrocarbons. We highlight the molecular picture of the interfacial processes and their implication to the electronic, optical, and wetting properties of 2D materials. Graphene is the most studied material system in this regard and will be the focus of this review. Other 2D materials, including

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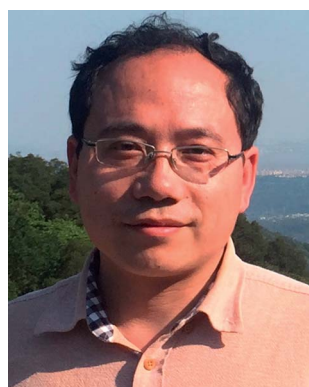
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BN, transition metal dichalcogenides, and 2D heterostructures, will be discussed when appropriate. Due to space constrain, we will limit the discussion to studies conducted at or close to room temperature and will not cover high temperature studies (e.g., oxidation) of 2D materials.

Water and oxygen are the most recognized environmental factor impacting properties of 2D materials. Both molecules physisorb and chemisorb onto many 2D materials and their effect was known since the research on carbon nanotubes. Recently, it was shown that high molecular weight hydrocarbon is another contaminant that can strongly adsorb onto 2D materials. Although the concentration of hydrocarbon in air (<ppm) is several orders of magnitude lower than that of O<sub>2</sub> and H<sub>2</sub>O, 2D materials surfaces can still be contaminated by hydrocarbons within seconds to hours because of their fast diffusion in air.

## 2 O<sub>2</sub>: p type charge doping

### 2.1 Charge doping of graphene

Molecular oxygen can adsorb onto graphene to result in hole doping. This effect is similar to that observed on carbon nanotubes, in which case it was suggested that endoperoxide

(i.e., chemical adsorption) is formed on the curved carbon surface as a result of O<sub>2</sub> adsorption.<sup>3,4</sup> Compared to carbon nanotubes, graphene has two significant differences: the absence of the high curvature and the 2D geometry. The former makes the formation of endoperoxide not energetically feasible while the latter makes it possible to trap molecules, including O<sub>2</sub> between graphene and a supporting substrate. As a result, the mechanism of O<sub>2</sub>-induced charge doping of graphene could be different from that of the carbon nanotubes. There has been extensive work to understand the interaction between O<sub>2</sub> and graphene. However, detailed molecular picture of the adsorption and charge doping has not been well understood, in part due to the difficulty to characterize the chemical nature of adsorbed oxygen species. Many surface sensitive spectroscopy techniques require ultra-high vacuum, which lead to the desorption of O<sub>2</sub> from the surface.

Ryu *et al.* reported a very detailed study of the charge doping of exfoliated graphene by O<sub>2</sub> using Raman spectroscopy, in which case the doping level of graphene can be extracted from the Raman G peak position and linewidth.<sup>5</sup> They found that the level of hole doping by O<sub>2</sub> is affected by two factors: the presence of water vapor and the mechanical coupling between graphene and the substrate. The effect of water is illustrated in Fig. 1a, where the G band position was measured on an exfoliated graphene as a function of various processing conditions. The G peak position shifted to higher wavenumber upon exposure to dry O<sub>2</sub> and shifted back upon flowing dry Ar (black and blue dots). This data suggests that O<sub>2</sub> reversibly hole dopes graphene (hole density *ca.*  $4 \times 10^{12}/\text{cm}^2$ ), which is also confirmed by field effect measurement. No noticeable shift in the Raman peak position was observed when the sample was exposed to wet N<sub>2</sub> (green dots). However, the presence of both H<sub>2</sub>O and O<sub>2</sub> caused a much larger shift in the G peak compared to the case of flowing O<sub>2</sub> alone, which is only partially restored by flowing dry Ar. This result shows that although water itself does not significantly dope graphene, it does assist the hole-doping of graphene by O<sub>2</sub>. The effect of graphene–substrate interaction is shown by comparing supported and suspended graphene (Fig. 1b). The supported graphene produced a large increase in



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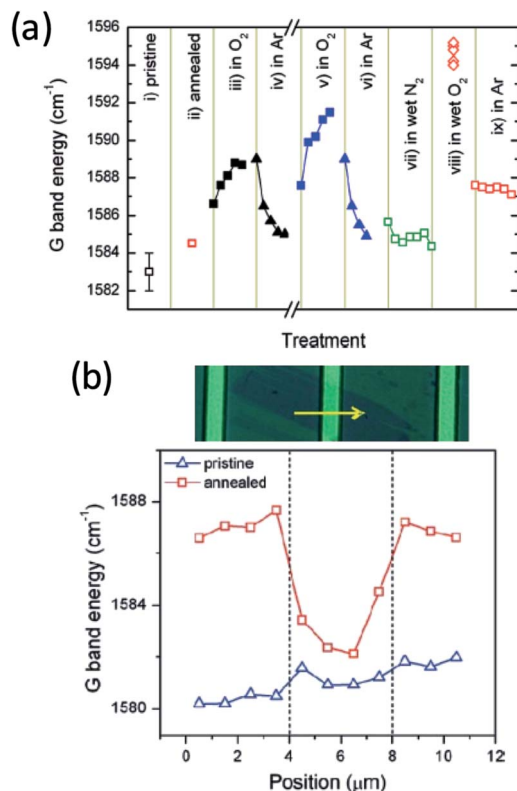


Fig. 1 (a) Effect of thermal treatment and O<sub>2</sub> on the Raman G peak shift of an exfoliated graphene sample. Higher G peak position is correlated with higher p doping in this case. (b) A linear scan of Raman G peak shift of an exfoliated graphene. As shown in the micrograph, the middle portion of this graphene sample was suspended over a trench that is ca. 4 μm in width (between 4–8 μm in the line scan). Reproduced with permission from Ryu, S.; *et al.*, *Nano Lett.*, 2010, 10, 4944. Copyright American Chemical Society.

the Raman G peak after annealing while the suspended portion showed a much smaller change. It should be noted that strain can change the Raman peak features as well. In a recent study, Lee *et al.* reported a Raman-based approach to separate the effect of strain and charge doping and showed that heating graphene to 150 °C is sufficient to activate the O<sub>2</sub> induced hole doping.<sup>6</sup>

Sato *et al.* studied O<sub>2</sub> adsorption on bilayer graphene using field effect measurements.<sup>7</sup> In their work, a field effect transistor was fabricated using an exfoliated bilayer graphene sample and exposed to O<sub>2</sub>; its transfer characteristics (*i.e.*, source–drain current as a function of back gate voltage) was used to quantify the degree of charge doping induced by O<sub>2</sub> adsorption. The shift of charge neutrality point in their FET measurement directly correlates with the degree of charge doping. The most interesting finding of their work is that the degree of O<sub>2</sub>-induced hole doping is a function of not only time but also the gate voltage. Specifically, positive gate voltage (*i.e.*, electrically electron-doped graphene) promotes the O<sub>2</sub> adsorption and negative gate voltage inhibits it (Fig. 2). In other studies, oxygen has been suggested to play a role in the hysteresis behavior of graphene FETs. Although water was believed to be the major contributing factor (see Section 3), the

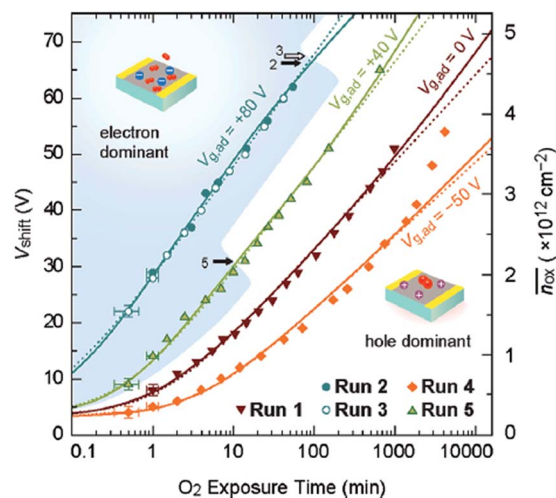


Fig. 2 Effect of gate voltage on the time dependence of O<sub>2</sub>-induced charge doping of bilayer graphene. The charge doping level is calculated using the shift of the charge neutrality point (V<sub>shift</sub>). Reproduced with permission from Satu, *et al.*, *Nano Lett.*, 2011, 11, 3468. Copyright American Chemical Society.

gate hysteresis of graphene FETs was observed even with a very short time of pulsed V<sub>g</sub> in dry oxygen environment.<sup>8</sup> Yang *et al.* suggested that the charge transfer between graphene and O<sub>2</sub> leads to a negatively charged adsorbate layer on the surface of graphene.<sup>8</sup>

The molecular mechanism of O<sub>2</sub> adsorption and charge doping has been under intense investigation. However, definitive conclusion has not been made due to challenges in characterizing the molecular and bonding structure of the adsorbed oxygen species. The covalent bonding of O<sub>2</sub> onto the basal plane of graphene, in the form of epoxide or endoperoxide, is not likely due to the absence of D peak in the Raman spectrum.<sup>5</sup> The most widely accepted model is that charge doping is mediated through an electrochemical mechanism, in which O<sub>2</sub> is reduced by electron transfer from graphene and the reduction products (*e.g.*, OH<sup>-</sup>) are stabilized by the substrate (*e.g.*, SiO<sub>2</sub>) and adsorbed water. This adsorption mode involves chemical transformation (*i.e.*, similar to chemisorption), yet at the same time it is reversible and does not produce chemical defects on graphene (*i.e.*, similar to physisorption). The variations in the doping within and between graphene samples can be explained by trapped O<sub>2</sub> and H<sub>2</sub>O between graphene and substrate. It was shown that water can diffuse between graphene and SiO<sub>2</sub>, forming a water layer of ca. 3.5 Å thickness.<sup>9</sup> The intercalation of water significantly reduced the hole-doping of graphene, supporting the idea that the O<sub>2</sub>-induced hole-doping is due to trapped species underneath graphene and/or interaction between SiO<sub>2</sub> and graphene. This mechanism also explains the effect of gate voltage on the adsorption of O<sub>2</sub>: if one assumes that the electron transfer is the rate limiting step of O<sub>2</sub> adsorption, then such process should be dependent on the electrochemical potential of graphene.<sup>7</sup> Specifically, increasing the potential (*i.e.*, electron doping) of graphene should increase the adsorption rate and reducing the potential (*i.e.*, hole



doping) should decrease the rate, as has been shown by the data in Fig. 2.

## 2.2 O<sub>2</sub> adsorption on transition metal dichalcogenides (TMDs)

Gao *et al.* reported that MoS<sub>2</sub> and WS<sub>2</sub> showed significant crack and quenching of PL after storage in air for several months, which the authors attributed to oxidation by O<sub>2</sub> and H<sub>2</sub>O.<sup>10</sup> Oxygen adsorption significantly impacts the operation of MoS<sub>2</sub> FET devices.<sup>10</sup> Qiu *et al.* observed significant increase of the on-state current in high vacuum compare to air on bi-layer MoS<sub>2</sub> FETs, which is an n-type device. Vacuum annealing at 350 K resulted in a further increase of on-state current while exposure to dry oxygen decreased the on-state current by as much as 100 times.<sup>11</sup> The surface oxygen-containing species, as determined by X-ray photoelectron spectroscopy (XPS), showed a 43% reduction when an air-exposed sample was annealed in UHV at 350 K for 24 hours. This 43% of oxygen-containing species are likely physisorbed given the low desorption temperature. These results suggest that hole doping by O<sub>2</sub> reduces the carrier density in MoS<sub>2</sub> and consequently decreases the on-state current.<sup>11</sup> Yue *et al.* studied the adsorption of various gases on MoS<sub>2</sub> by density functional theory calculation and found that both O<sub>2</sub> and H<sub>2</sub>O act as electron acceptors while NH<sub>3</sub> is an electron donor.<sup>12</sup>

The optical properties of monolayer TMDs can be also greatly affected by O<sub>2</sub>. Tongay *et al.* demonstrated the modulation of the photoluminescence (PL) intensity of monolayer TMDs by O<sub>2</sub> and H<sub>2</sub>O (Fig. 3).<sup>13</sup> They showed that the vacuum annealing process greatly enhanced PL intensity by thermally desorbing initial contaminants and organic residues from the surfaces of TMDs. After the vacuum annealing, the PL intensity of

monolayer MoS<sub>2</sub> became extremely sensitive to O<sub>2</sub> and H<sub>2</sub>O environments. Inert gases such as Ar and N<sub>2</sub> did not affect the PL intensity, and the change in PL intensity by O<sub>2</sub>/H<sub>2</sub>O was completely reversible, again indicating physisorbed nature for these species. The PL intensity response was almost instantaneous and proportional to the O<sub>2</sub> or H<sub>2</sub>O pressure.<sup>13</sup> Moreover, the enhancement of PL intensity was more significant when MoS<sub>2</sub> was exposed to ambient condition (O<sub>2</sub> and H<sub>2</sub>O together) compare to the individual exposure of O<sub>2</sub> and H<sub>2</sub>O, again suggesting electrochemical p-doping by O<sub>2</sub> is at play.<sup>13</sup> It was suggested that p doping by O<sub>2</sub> reduces the charge carrier density, which could destabilize exciton by forming trion and therefore reduces PL intensity. It is interesting to note that WSe<sub>2</sub>, a p type semiconductor, showed the opposite behavior from MoS<sub>2</sub>, *i.e.*, O<sub>2</sub> exposure reduces the PL intensity. This observation can be again explained by the effect of p doping by O<sub>2</sub>, which increases the major charge carrier density in WSe<sub>2</sub> and reduces PL intensity by forming trion. In a more recent study, Nan *et al.* reported significant PL enhancement on defected area of MoS<sub>2</sub> after the sample is annealed at high temperature, which was explained by the same mechanism.<sup>14</sup>

The effect of air on the photocurrent of the MoS<sub>2</sub> monolayer was also reported. Zhang *et al.* measured the source–drain current at fixed source–drain and gate voltages under various illumination light power density ( $\lambda = 532$  nm), and observed much larger photocurrent decay in vacuum compare to ambient air environment.<sup>15</sup> Another study reported similar result using deep ultraviolet light ( $\lambda = 220$  nm) excitation in N<sub>2</sub> and O<sub>2</sub> gas environments.<sup>16</sup>

## 3 H<sub>2</sub>O: gating hysteresis

Water can physisorb onto both 2D materials and their supporting substrates. Being an impermeable membrane, 2D materials can effectively trap water between itself and the substrate.<sup>17</sup> The electrical measurements of 2D-material-based FETs often show large hysteresis in the transfer characteristics (*i.e.*, source–drain current *vs.* gate voltage).<sup>18–25</sup> It is commonly agreed that water is a major contributor to the hysteresis although the exact mechanism is still under investigation. It should be noted that chemisorption of water on 2D materials has also been extensively studied, although it will not be reviewed here. For example, water (but not O<sub>2</sub>, H<sub>2</sub>, or NH<sub>3</sub>) can react with line defects within Ru(0001)- and Cu(111)-supported graphene to result in physically damage of the film.<sup>26</sup>

### 3.1 Graphene FETs

Lohmann *et al.* studied the gate hysteresis in ambient conditions using FETs fabricated on mechanically exfoliated graphene.<sup>27</sup> As shown in Fig. 4, subjecting the FET to positive (negative) gate voltage ( $V_{bg}$  or  $V_g$ ) moved the charge neutrality point to the same direction, indicating that graphene is more hole (electron) doped as a result of the gating history. Both low  $V_g$  sweeping rates and large  $V_g$  scan range enhanced the shift in charge neutrality point. When graphene FETs were kept under vacuum ( $3 \times 10^{-5}$  mbar) for several hours, significant shift of

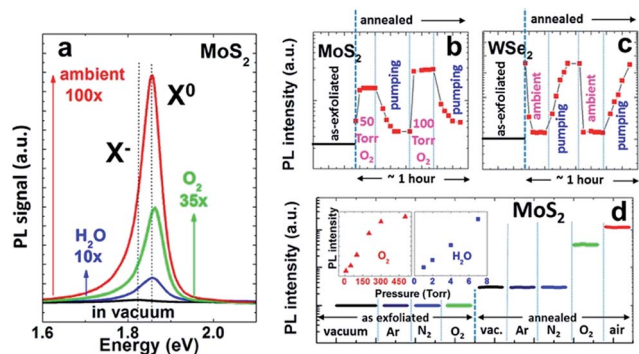


Fig. 3 Effects of different gas environments on the PL intensity of annealed monolayer TMDs. (a) Change in PL intensity on MoS<sub>2</sub> in H<sub>2</sub>O, O<sub>2</sub>, and ambient (H<sub>2</sub>O and O<sub>2</sub>) environments. Trion X<sup>-</sup> and exciton X<sup>0</sup> peak positions are indicated. Modulation of the PL intensity of (b) monolayer MoS<sub>2</sub> with O<sub>2</sub> exposure (50 and 100 Torr), and (c) monolayer WSe<sub>2</sub> with ambient air (760 Torr). The opposite response was observed in MoS<sub>2</sub> (n-type) and WSe<sub>2</sub> (p-type). (d) Effect of Ar, N<sub>2</sub>, O<sub>2</sub>, and air on the PL intensity of as-exfoliated and vacuum annealed monolayer MoS<sub>2</sub>. Inset: PL intensity as a function of O<sub>2</sub> and H<sub>2</sub>O pressure. The PL intensities in panels (b)–(d) are log scale. Adapted with permission from Tongay, S. *et al.*, *Nano Lett.*, 2013, **13**, 2831–2836. Copyright American Chemical Society.



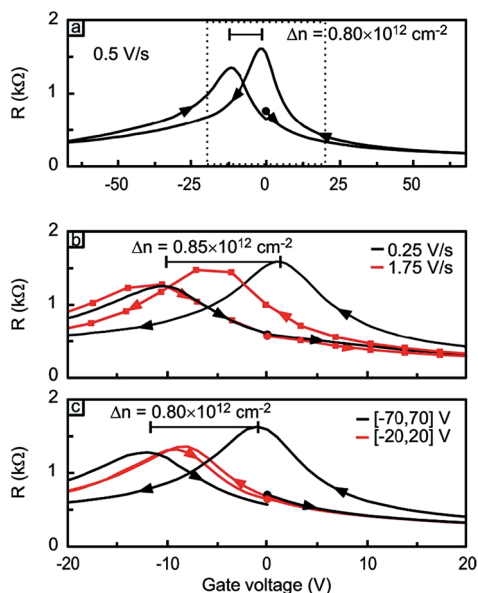


Fig. 4 Gate hysteresis of graphene FETs. (a)  $V_g$  sweep started from 0 V (black dot) to +70 V to -70 V to 0 V. The arrows indicate the sweep direction. (b) Change in gate hysteresis with two different  $V_g$  scan rate.  $V_g$  interval was  $\pm 70$  V (c) the change in gate hysteresis with two different  $V_g$  interval. The scan rate of  $0.5 \text{ V s}^{-1}$  was used. Adapted from Lohmann, T. *et al.*, *Nano Lett.*, 2009, 9, 1973–1979. Copyright American Chemical Society.

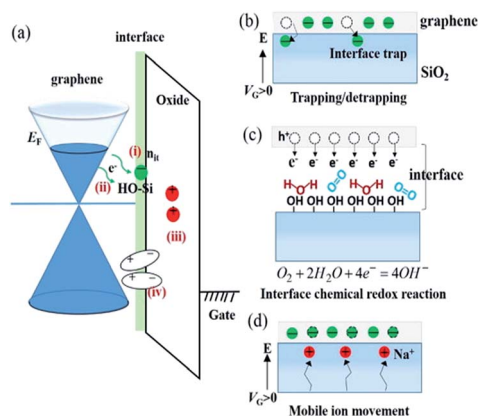


Fig. 5 Proposed mechanisms of hysteresis of graphene FET. (a) Energy diagram of FET device. (b) Charge trapping at the surface of  $\text{SiO}_2$ . (c) Redox reaction between graphene and trapped  $\text{H}_2\text{O}/\text{O}_2$ . (d) Mobile ion mechanism. Reproduced with permission from Feng, T.; *et al.*, *Carbon*, 2014, 78, 250. Copyright Elsevier.

charge neutrality point toward zero  $V_{bg}$  occurred, suggesting gradual desorption of hole doping adsorbates, presumably  $\text{O}_2$ . The hysteresis behavior was also diminished in vacuum.<sup>27</sup> Analogous to the hysteresis observed with carbon nanotube FETs,<sup>28</sup> it was proposed that water molecules adsorbed on the graphene or  $\text{SiO}_2$  surface in ambient condition, and the hysteresis was attributed to the charge trapping mediated by water molecules and the migration of the mobile ions (*e.g.*,  $\text{Na}^+$ ) in the  $\text{SiO}_2$  substrate (Fig. 5).<sup>29</sup>

The electrochemical  $\text{O}_2/\text{H}_2\text{O}$  redox couple was also suggested as a possible mechanism for the hysteresis observed in FET devices (Fig. 5b). Veligura *et al.* measured the transfer characteristics of graphene FET as a function of relative humidity.<sup>25</sup> They observed that short exposure to water vapor did not produce hysteresis while high humidity levels did. In addition, ethanol vapor did not induce hysteretic behavior nor doping effect on graphene FETs. Given the similar dipole moment of ethanol and water, 1.68 D and 1.85 D, respectively, the result shows that the polar nature of water molecules was not a significant factor in the observed hysteresis.<sup>25</sup> They proposed that the  $\text{O}_2/\text{H}_2\text{O}$  redox reaction could change the local pH and was responsible for the hysteresis. Similar claims were also made by Xu *et al.*<sup>30</sup> Assuming surface-adsorbed water is in equilibrium with air ( $\text{pH} = \text{ca. } 6$ ), the Fermi level of undoped graphene ( $-4.6 \text{ eV}$ )<sup>31</sup> lies above the electrochemical potential of the solution ( $-5.3 \text{ eV}$  relative to vacuum level). Hence, electrons can transfer from graphene to  $\text{O}_2$  solvated in the adsorbed water layer, resulting in hole doping of graphene in air. Back gating will change the initial electrochemical equilibrium between graphene and the  $\text{O}_2/\text{H}_2\text{O}$  redox couple, and the charge transfer occurs continuously under the sweeping of  $V_g$  to establish a new equilibrium.<sup>30</sup> Feng *et al.* reported the temperature dependence of the hysteresis in ambient condition.<sup>32</sup> They observed a shift of charge neutrality point toward 0 V as the temperature was increased from 300 K to 380 K,<sup>32</sup> which is consistent with the desorption of hole doping molecules (Fig. 6a). The hysteresis also increased upon heating (Fig. 6b) and this observation is consistent with charge trapping,  $\text{O}_2/\text{H}_2\text{O}$  redox, and mobile ion mechanisms.<sup>32</sup> In contrast, Joshi *et al.* observed that the transconductance hysteresis persisted even after vacuum annealing at 200 °C for  $\sim 20$  h; they also estimated the density of water-related electron traps to be  $\sim 2.4 \times 10^{10} \text{ cm}^{-2} \text{ eV}^{-1}$ .<sup>18</sup> On the other hand, Wang *et al.* reported that at low temperature ( $< 0$  °C), the hysteresis changes its direction, *i.e.*, subjecting the FET device to positive gate voltage decreases the charge neutrality point.<sup>20</sup> It was proposed that the strong dipole of an ice layer on graphene was responsible for the effect. Similar observations was also made by Liao *et al.*, who reported the reversion of the hysteresis behaviour at  $\sim 215$  K and proposed that the frozen electron-trap states of  $\text{H}_2\text{O}$  can be turned into the hole-trapping states as the temperature decreases, thus result in the reversion of the hysteresis.<sup>19</sup>

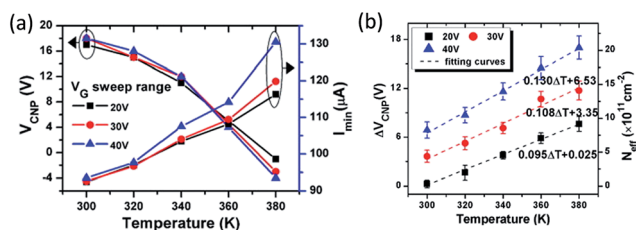


Fig. 6 Temperature dependence of (a) charge neutrality point and (b) shift in charge neutrality point of a graphene FET. Adopted with permission from Feng, T.; *et al.*, *Carbon*, 2014, 78, 250. Copyright Elsevier.



Consistent with the water-assisted mechanism, the hysteresis can be suppressed by the surface treatment of the substrate. For example, by applying phenyl-terminated organosilane self-assembled monolayer onto the dielectric surface, improvement in mobility, hysteresis, and bias stress stability of graphene FETs were observed.<sup>33</sup> Many other passivation layer on the dielectric surface were also used, such as poly(methyl methacrylate) (PMMA),<sup>27</sup> parylene,<sup>34</sup> and hexamethyldisilazane (HMDS).<sup>18</sup>

### 3.2 MoS<sub>2</sub> FETs

Similar to the case of graphene, single layer MoS<sub>2</sub> FETs also exhibit hysteresis behaviour in ambient conditions. Late *et al.* showed that the threshold gate hysteresis steadily increased with increased relative humidity, and vacuum and dry air environments both reduced hysteresis behavior. These results suggest that adsorbed water molecules is responsible for the hysteretic behavior.<sup>35</sup> Interestingly, keeping the device in the dark suppresses the threshold gate hysteresis in comparison to white illumination (radiant flux density  $\sim 0.7 \text{ mW cm}^{-2}$ ).<sup>35</sup> As the illumination was turned off, charge carrier concentration decreases and the charge transfer can be suppressed. Suppression of the hysteresis was further demonstrated by protective coating of MoS<sub>2</sub> FETs with amorphous Si<sub>3</sub>N<sub>4</sub>. In contrast to graphene FETs, the threshold gate hysteresis observed in vacuum was not negligible and also observed with suspended MoS<sub>2</sub> FETs in vacuum, suggesting additional mechanisms, possibly intrinsic to the MoS<sub>2</sub> material itself, is at play.<sup>36</sup>

## 4 Airborne hydrocarbons

There is a rich literature of airborne hydrocarbon adsorption on high energy surfaces, such as metals and ceramics. All high energy surfaces get contaminated by airborne hydrocarbon contamination.<sup>37</sup> In fact, adventitious carbon peak has been used as a binding energy reference for XPS spectrum.<sup>38,39</sup> What has not been widely recognized is that many low energy surfaces, such as graphene and other 2D materials, also adsorb airborne hydrocarbon when exposed to air and such adsorption significantly changes their surface properties.

### 4.1 Wetting transition of graphene

Early studies by Schrader investigated contamination of graphite by ultra-high vacuum (UHV) surface science techniques and water contact angle measurement.<sup>40,41</sup> It was reported that graphite surface cleaned in UHV showed a low water contact angle (*i.e.*, more polar) than that prepared in air and it was suggested that surface contamination is responsible for this effect.<sup>40</sup> However, spectroscopic evidence of hydrocarbon contamination was not presented in that study and the community still overwhelmingly accepted that graphite is a hydrophobic material.

Airborne hydrocarbon contamination of graphene was systematically studied by a number of recent studies. Li *et al.* reported that the water contact angle of a freshly prepared chemical vapor deposition (CVD)-grown graphene (supported

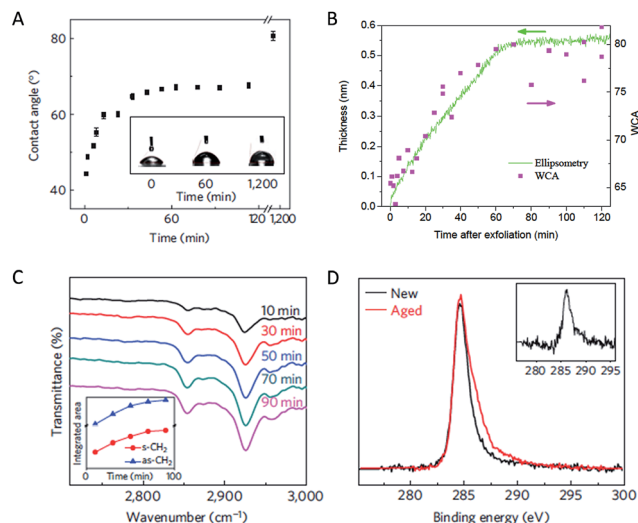


Fig. 7 Adsorption of airborne hydrocarbon onto graphitic surfaces. (A) Hydrophilic-to-hydrophobic wetting transition of a copper-supported graphene sample in air. The inset shows selected contact angle (WCA) data. (B) High correlation between wettability and thickness of adsorbed hydrocarbon for an exfoliated HOPG sample in air. (C) C–H vibration region of ATR-FTIR spectra that were collected from a copper-supported graphene sample exposed to air. The inset shows the intensity of the symmetrical (s) and anti-symmetrical stretching (as) peaks of  $-\text{CH}_2-$  as a function of time. (D) Effect of aging in air (several days) on the carbon XPS peak of a copper-supported graphene. The inset shows the difference spectrum. Panel (A) (C) (D) are adapted with permission from Li *et al.*, *Nature Mater.*, 2013, 12, 925. Copyright Nature Publishing Group. Panel (B) is adapted with permission from Kozbial, *et al.*, *Carbon*, 2014, 74, 218. Copyright Elsevier.

on a Cu foil) is about 42°, significantly lower than the commonly accepted value of 90°. It was shown that airborne hydrocarbons adsorb onto graphene surface within minutes to hours and the surface becomes hydrophobic as a result.<sup>42</sup> Using graphite as a model, Kozbial *et al.* showed that the surface accumulates *ca.* 0.5 nm thick of hydrocarbon from air, which is responsible for a wetting transition from *ca.* 64° (freshly cleaved sample) to *ca.* 80° (air-aged sample, Fig. 7).<sup>43</sup> Attenuated total reflection (ATR) FTIR and XPS data suggest the presence of hydrocarbon on the surface, which can be removed by high temperature annealing and UV/O<sub>3</sub> treatment.<sup>42</sup> These results are reproduced by a number of parallel and follow-up studies using supported and partially suspended graphene as well as graphite.<sup>44–51</sup> In particular, Ondarçuhu *et al.* measured water contact angle on partially suspended graphene and concluded that a totally suspended graphene should have a water contact angle of 85° ± 5°.<sup>52</sup> In a more recent work, Kozbial *et al.* also used dynamic contact angle measurements to assess the role of defects in the wettability of freshly exfoliated graphite.<sup>53</sup> They argued that the advancing contact angle reflects the wettability of defect free graphite while the density of defects in graphite determines its receding contact angle. They reported an advancing WCA for pristine graphite to be 68.6°, which indicates that graphitic carbon is intrinsically mildly hydrophilic. Note that the contact angle of graphitic materials significantly depends on their supporting substrate. This phenomenon, termed (partial)



wetting transparency,<sup>42,54,55</sup> is the reason behind the large variation of contact angles reported for Cu-supported graphene (42°), suspended graphene (85°), and graphite (64–68.6°).

Wettability of a surface is directly linked to its surface free energy. Kozbial *et al.* showed that the surface energy (Fowkes model) of a clean copper-supported graphene is *ca.* 25% higher than that of a contaminated sample.<sup>56</sup> A surprising finding of their work is that the surface energy of clean graphene and graphite contains a significant polar contribution. This result contrast with the traditional view that graphitic materials are non-polar. The origin of such polar contribution is not clear but could originate from  $\pi$ -hydrogen bonding interactions and charge doping by the substrate.

It should be noted that none of the recent studies have verified the surface cleanness of their samples. Instead, the change of contact angle was used as an indication that the surface is getting contaminated and that the freshly prepared surface is assumed to be reasonably clean. The reported contact angle values and kinetics showed some variations, which is expected as the type and concentration of airborne hydrocarbon will depend on the location. It will be very interesting to measure water contact angle on a surface verified to be clean, as in the work of Schrader, while at the same time, address the water evaporation issue in that work.<sup>40,41</sup> Within this context, it is worth noting that many plastics emits hydrocarbon and as a result, glovebox and cleanroom should not be assumed to be hydrocarbon-free.<sup>42,57,58</sup>

The interaction between the hydrocarbon and the graphitic carbon substrates are likely physisorption in nature. The adsorbed species can be removed by a thermal annealing in vacuum without introducing significant defects into the carbon materials.<sup>42,43</sup> The weak binding of the contaminant poses significant challenges in their structural characterization. Traditional surface science techniques, such as XPS and transmission electron microscopy, rely on ultra-high vacuum, which inevitably results in a partial or complete desorption of the contaminant. Fortunately, significant efforts have been made to adopt these techniques for ambient pressure analysis (*e.g.*, ambient pressure XPS).<sup>59</sup> FTIR has been extensively used in the recent literature as it has the needed sub-monolayer sensitivity and chemical specificity.<sup>42–44,46</sup> Tip-enhanced FTIR is a particular interesting tool because it provides the much needed spatial resolution.<sup>60</sup> Other characterization tools has also been used to characterize the surface, such as ellipsometry and force measurement.<sup>43,44,46</sup> Unfortunately, these methods do not provide the structural information of the contaminant.

## 4.2 Effect on electrochemistry of graphene

The presence of hydrocarbon significantly decreases the rate of electron transfer from a graphene electrode to solution redox couples. It was long believed that the basal plane of graphene and graphite has very low electrochemical activity compared to metal electrodes, due to their low density of state and absence of adsorption of redox couples. It is now understood that such low activity is, at least in part, due to surface contamination by hydrocarbons.<sup>47,61,62</sup> Several research groups, in particular

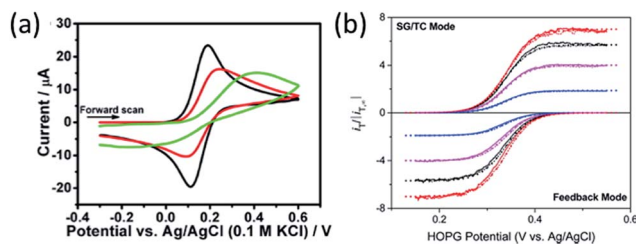


Fig. 8 (a) Effect of air exposure on the electrode activity. The cyclic voltammetry was collected using a freshly cleaved HOPG electrode; the electrolyte was 1 mM  $\text{Fe}(\text{CN})_6^{4-}$  in 0.1 M KCl. The HOPG was left in air for 0 min (black), 1 h (red), and 3 h (green). Reproduced with permission from Patel, A. N.; *et al.*, *J. Am. Chem. Soc.*, 2012, **134**, 20117. (b) Nanogap voltammograms collected on an HOPG surface with reduced hydrocarbon contamination. The electrolyte was 0.3 mM of (ferrocenylmethyl)trimethylammonium in 50 mM KCl. Reproduced with permission from Chen, R.; *et al.*, *Anal. Chem.*, 2016, **88**, 8323. Copyright American Chemical Society.

Unwin, Dryfe, and Amemiya have shown that the electrochemical activity of graphite and graphene is sensitive to air exposure and suggested that hydrocarbon contamination lead to a decrease of electrode performance (Fig. 8a).<sup>47,57,61–65</sup> These data suggests that airborne hydrocarbon contamination on graphene persists in water. The Amemiya group also showed that by partially reducing hydrocarbon contamination on the surface, the electrochemical activity of graphene and graphite can be drastically improved.<sup>47,61,65</sup> In one study, they used scanning electrochemical microscopy-based nanogap voltammetry method to measure the heterogeneous electron transfer rate constant on a highly oriented pyrolytic graphite (HOPG) electrode. During the electrode fabrication process, the HOPG surface was protected from airborne hydrocarbon contamination using a water adlayer.<sup>66</sup> Their study reported extremely high rate constants ( $\geq 12 \text{ cm s}^{-1}$ ) that are many orders of magnitude higher than previous believed possible for HOPG (Fig. 8b).<sup>67</sup>

## 4.3 Airborne hydrocarbon contamination of other 2D materials

Several other 2D materials, including  $\text{WS}_2$ ,  $\text{MoS}_2$ , and BN, also undergo the same hydrocarbon contamination when exposed to ambient air. Chow *et al.* prepared  $\text{WS}_2$  samples on  $\text{SiO}_2$  and reported that the freshly prepared sample showed an advancing water contact angle of *ca.* 70° and for air-aged sample the value increases to *ca.* 83°.<sup>68</sup> Similarly, Kozbial *et al.* showed that freshly exfoliated  $\text{MoS}_2$  has a water contact angle of 69° that increases to 89° after 1 day of exposure in air.<sup>69</sup> Hydrocarbon contamination was proposed to be responsible for the superhydrophobic behavior of BN nanotubes.<sup>70</sup> Li *et al.* studied the hydrocarbon adsorption on single layer BN grown on Cu, Ge, and Ni substrates. In all the three cases, they observed an increase of water contact angle (from *ca.* 63° to *ca.* 86°) as the freshly prepared sample ages in air. In a related study, Annamalai *et al.* reported wettability of a number of van der Waals heterostructures (*e.g.*,  $\text{WS}_2/\text{BN}$ , graphene/ $\text{BN}$ ,  $\text{MoS}_2/\text{WS}_2$ ).<sup>71</sup>



Their data was taken on thermally annealed samples and the result suggests contribution from the sub-layer to the wettability, *i.e.*, partial wetting transparency.<sup>54,55</sup>

The contamination does not noticeably impact the AFM imaging of the 2D material in the topography mode although it does change its surface potential.<sup>51</sup> The hydrocarbon contaminant form nanoscale bubbles when two pieces of 2D material are stacked together to create a van der Waals heterostructure.<sup>72</sup> These experimental evidence suggest that the adsorbed hydrocarbons behave like a liquid on the surface of 2D materials. Many of the applications of van der Waals heterostructures rely on their atomic cleanness and therefore, it will be important to understand and control their surface contamination by airborne hydrocarbons.<sup>4,73,74</sup>

## 5 Conclusion and outlook

Due to their unique geometry, the properties of 2D materials can be significantly impacted by adsorption of molecules from ambient environment. Understanding and controlling such environmental factors played a key role in revealing the true nature of 2D materials, such as the extreme charge mobility and high electrochemical activity of graphene, and the true surface energy of 2D materials. Within this context, the effect of O<sub>2</sub> and H<sub>2</sub>O are now widely appreciated. In contrast, airborne hydrocarbon has not received as much attention, in part due their low concentration in air. However, as we showed, airborne hydrocarbon contamination of many 2D materials is fast and their impact on the wetting and electrochemical properties is enormous.

Looking forward, it remains a challenge to fully understand the interaction between ambient-present molecules and 2D materials at the molecular level. For example, the mechanism for the O<sub>2</sub>-induced charge doping still lacks definitive experimental support; the chemical nature of the hydrocarbon contaminant is yet to be fully characterized. Addressing these fundamental questions is a key component in understanding the intrinsic properties of 2D materials and improving their performances in various devices. A major technical challenge in these studies is the lack of spectroscopic tools that can probe the 2D material surface with high surface sensitivity and spatial resolution at ambient environment. The rapid development of ambient pressure XPS, environmental TEM, and AFM-FTIR may provide the much-needed help in these cases.<sup>59,60,75</sup> For studies of hydrocarbon contamination, another challenge is the availability of a hydrocarbon-free ambient environment. The 2D materials are sensitive to even parts-per-trillion level of hydrocarbon vapor. Maintaining such a low hydrocarbon concentration in ambient pressure, which is required for wetting and electrochemical studies, requires special purification of air and solvents as well as eliminating hydrocarbon emission sources (*e.g.*, plastic tubing, oil pump) in the experimental setup.

Despite these challenges, exploring the interactions between ambient molecules with 2D materials will be extremely rewarding. At the bare minimum, the learnings are key to improve the reproducibility of devices (*e.g.*, FETs), and material properties (*e.g.*, PL, wettability). In the case of graphitic

materials, the recent studies have already revealed clean graphene/graphite as completely different from their 'dirty' counterparts.<sup>76</sup> Exploiting these new material properties will lead to new applications and device concepts.

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